Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/616,162	LI, JIANYING	
Examiner	Art Unit	
Randolph Chu	2624	

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	SEAR	CHED	
Class	Subclass	Date	Examiner
382	275	12/4/2007	RIC
382	260	12/4/2007	RIC
382	132	12/4/2007	RIC

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH N (INCLUDING SEAR)		)
	DATE	EXMR
EAST	12/5/2007	. RIC
Inventor Name Search	12/5/2007	RIC
consult with wenpeng Chen	1/10/2007	RIC
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